

# FQU4N25-VB Datasheet

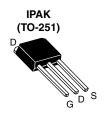
## **Power MOSFET**

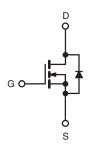
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	250				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 1.1				
Q <sub>g</sub> (Max.) (nC)	14				
Q <sub>gs</sub> (nC)	2.7				
Q <sub>gd</sub> (nC)	7.8				
Configuration	Single				

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling







N-Channel MOSFET

PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	250	V
Gate-Source Voltage		$V_{GS}$	± 20	v
Continuous Drain Current	1_	3.8	А	
Continuous Drain Current $V_{GS} \text{ at } 10 \text{ V} \qquad \frac{T_C = 25}{T_C = 100}$		I <sub>D</sub>		2.4
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	15	
Linear Derating Factor		0.33	W/°C	
Linear Derating Factor (PCB Mount)e		0.020	W/-C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	130	mJ
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	3.8	Α
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	4.2	mJ
Maximum Power Dissipation	Power Dissipation T <sub>C</sub> = 25 °C		42	W
Maximum Power Dissipation (PCB Mount)e	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.5	
Peak Diode Recovery dV/dtc	dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stq</sub>	- 55 to + 150	00	
Soldering Recommendations (Peak Temperature)d	for 10 s	_	260	°C

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 50 \text{ V}$ ; starting  $T_J = 25 \text{ °C}$ , L = 14 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 3.8 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 3.8 \text{ A}$ ,  $dI/dt \le 90 \text{ A/µs}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150 \text{ °C}$ .
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material) .



THERMAL RESISTANCE RATINGS					
PARAMETER	UNIT				
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	50		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	110	°C/W	
Maximum Junction-to-Case	R <sub>thJC</sub>	-	3.0		

#### Note

a. When mounted on 1" square PCB ( FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		•					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		250	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.36	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zoro Coto Voltago Drain Current		V <sub>DS</sub> =	V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 200 V	V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 2.3 A^b$	-	1.1	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 2.3 A <sup>b</sup>	1.5	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	260	-	
Output Capacitance	Coss	]	$V_{DS} = 25 \text{ V},$	-	77	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	0 MHz, see fig. 5 <sup>c</sup>	-	15	-	
Total Gate Charge	Qg				-	14	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V},$ see fig. 6 and $13^{b, c}$	-	-	2.7	nC
Gate-Drain Charge	Q <sub>gd</sub>	1	See fig. 6 and 13-5		-	7.8	1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 125 V, $I_{D}$ = 4.4 A, $R_{G}$ = 18 $\Omega$ , $R_{D}$ = 28 $\Omega$ , see fig. 10 <sup>b, c</sup>		-	7.0	-	- ns
Rise Time	t <sub>r</sub>			-	13	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	20	-	
Fall Time	t <sub>f</sub>			-	12	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s					,	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	3.8	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	15	A .
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 3.8  \text{A},  V_{GS} = 0  V^b$		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 25 °C 1	T 05 90 1 444 31/31 400 1/2 b		200	400	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 4.4  \text{A, dI/dt} = 100  \text{A/}\mu\text{s}^{\text{b}}$		-	0.93	1.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	-on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )	

- Notes a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq 300~\mu s$ ; duty cycle  $\leq 2~\%$ .



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

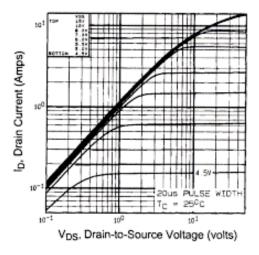


Fig. 1 - Typical Output Characteristics,  $T_C$  = 25 °C

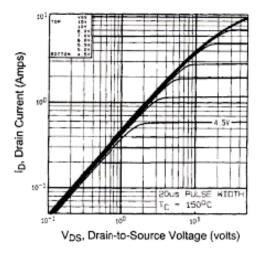


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

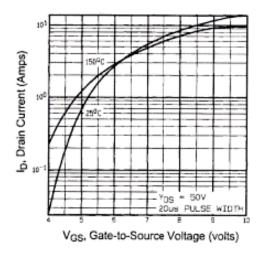


Fig. 3 - Typical Transfer Characteristics

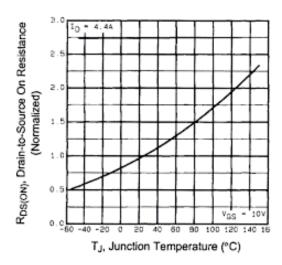


Fig. 4 - Normalized On-Resistance vs. Temperature



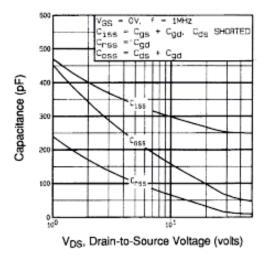


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

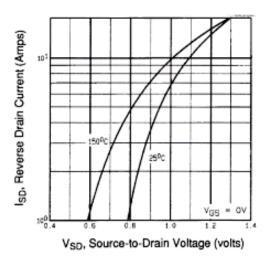


Fig. 7 - Typical Source-Drain Diode Forward Voltage

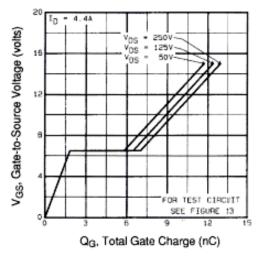


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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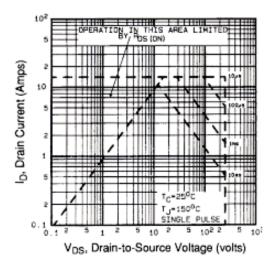


Fig. 8 - Maximum Safe Operating Area



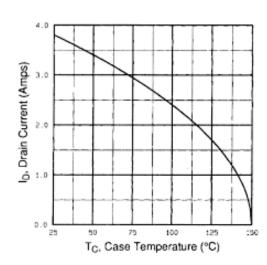


Fig. 9 - Maximum Drain Current vs. Case Temperature

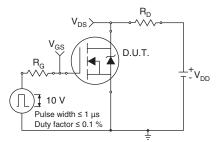


Fig. 10a - Switching Time Test Circuit

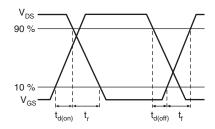
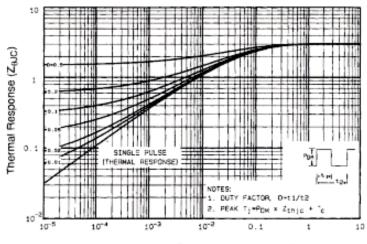


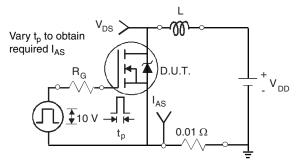
Fig. 10b - Switching Time Waveforms

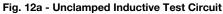


t<sub>1</sub>, Rectangular Pulse Duration (seconds)

Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







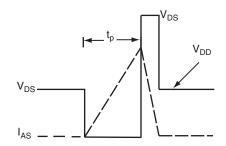


Fig. 12b - Unclamped Inductive Waveforms

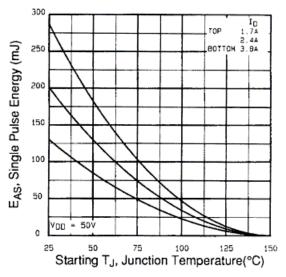


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

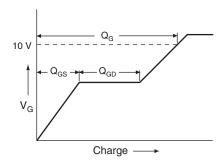


Fig. 13a - Basic Gate Charge Waveform

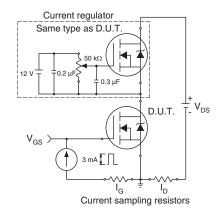
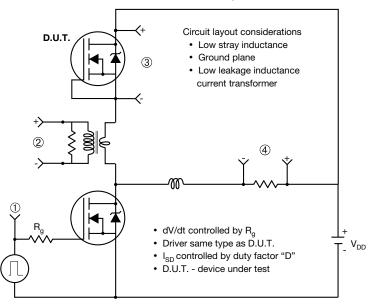


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



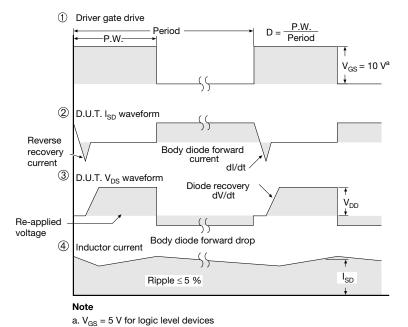
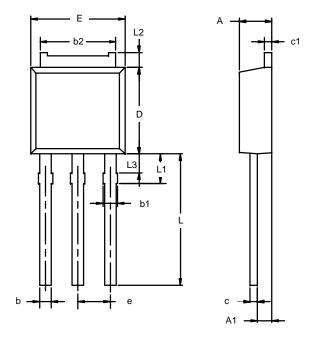


Fig. 14 - For N-Channel



### **TO-251AA**



Note:	Dimension	L3 is for	reference	only.
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	MILLIN	IETERS	INC	HES
Dim	Min	Max	Min	Max
Α	2.21	2.38	0.087	0.094
<b>A</b> 1	0.89	1.14	0.035	0.045
b	0.71	0.89	0.028	0.035
b1	0.76	1.14	0.030	0.045
b2	5.23	5.43	0.206	0.214
С	0.46	0.58	0.018	0.023
с1	0.46	0.58	0.018	0.023
D	5.97	6.22	0.235	0.245
Е	6.48	6.73	0.255	0.265
е	2.28 BSC		0.090	BSC
L	3.89	9.53	0.153	0.375
L1	1.91	2.28	0.075	0.090
L2	0.89	1.27	0.035	0.050
L3	1.15	1.52	0.045	0.060



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